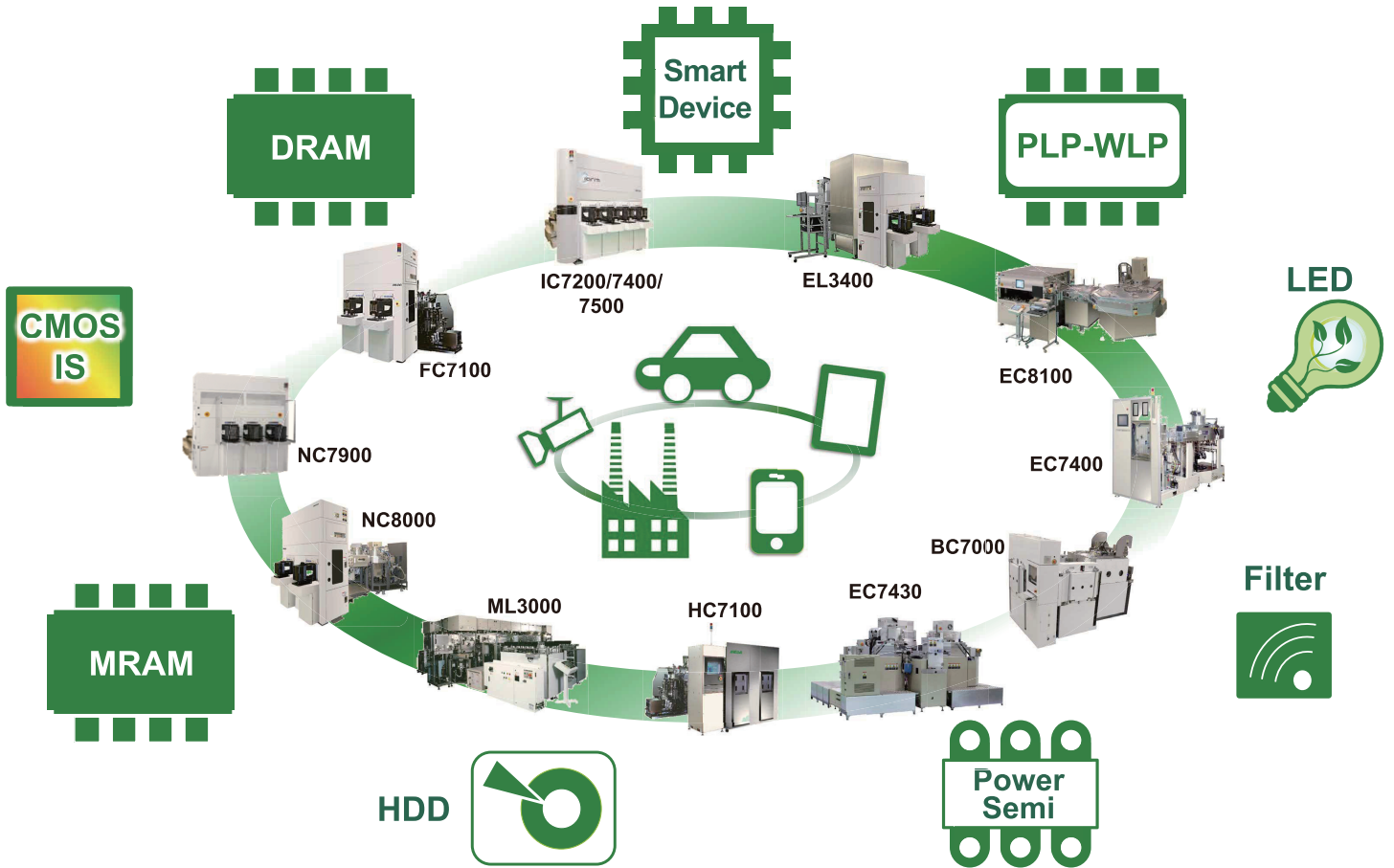
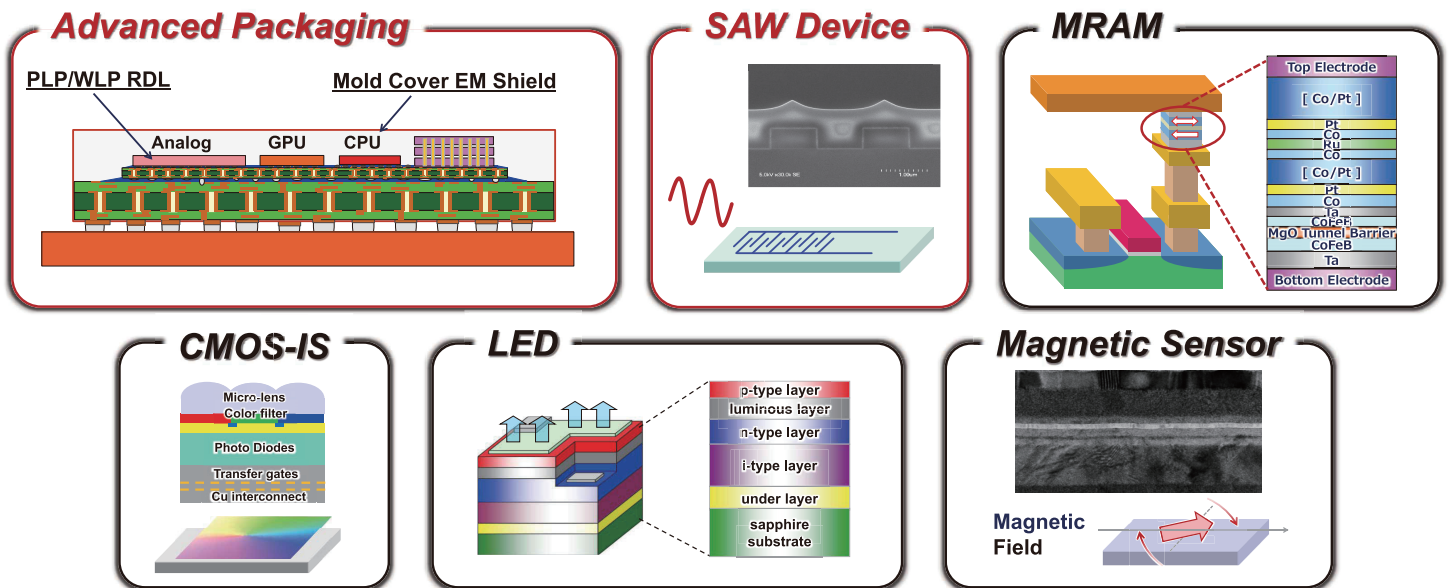


Equipment Products Line Up

Explore vacuum technology to the future

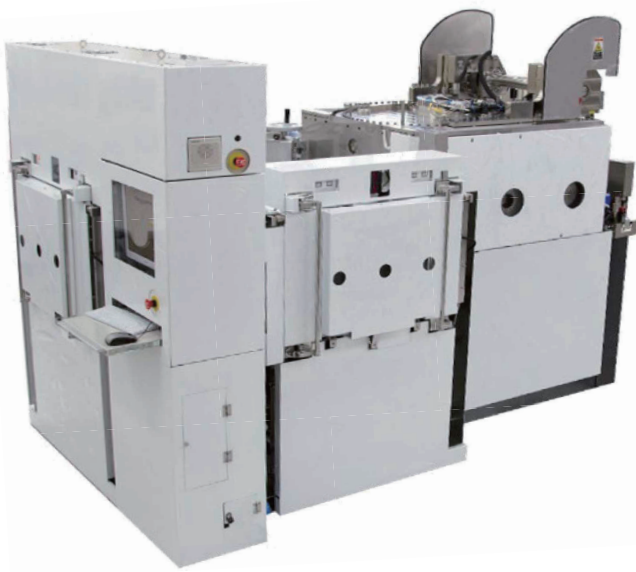


Major Process Applications



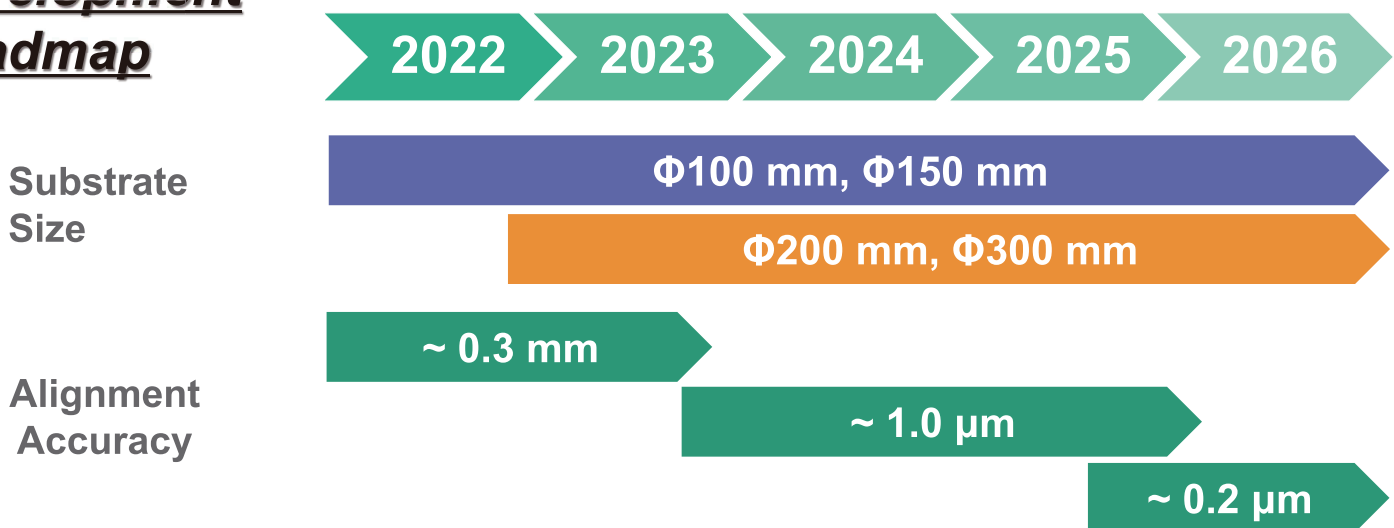
Atomic Diffusion Bonding (ADB) Equipment BC7000

Applicable for High-Volume Manufacturing and R&D
Deposition & Bonding Combination Module



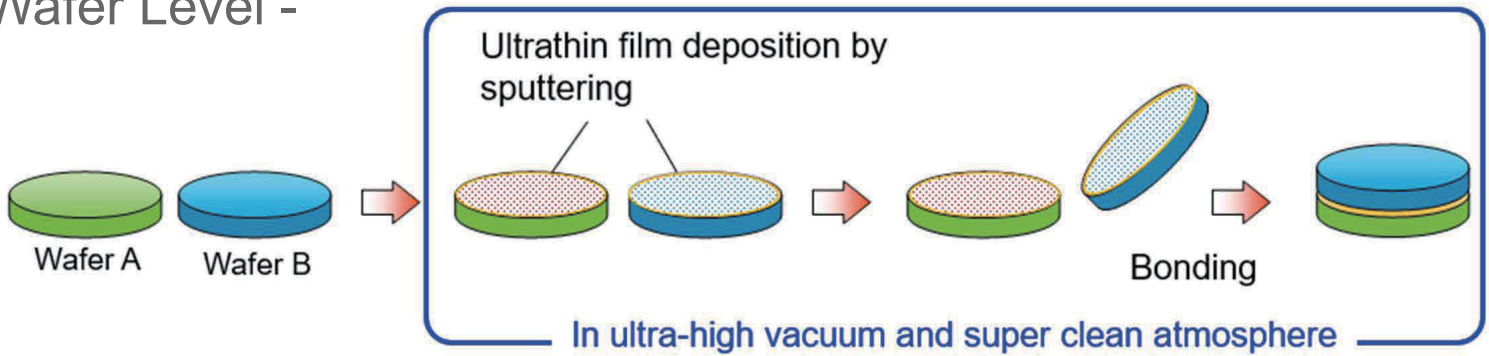
- Bond at room temperature
- No applied pressure required
- Use any metal as bonding layer
- Bond similar or dissimilar materials
- High strength permanent bonds

Development Roadmap

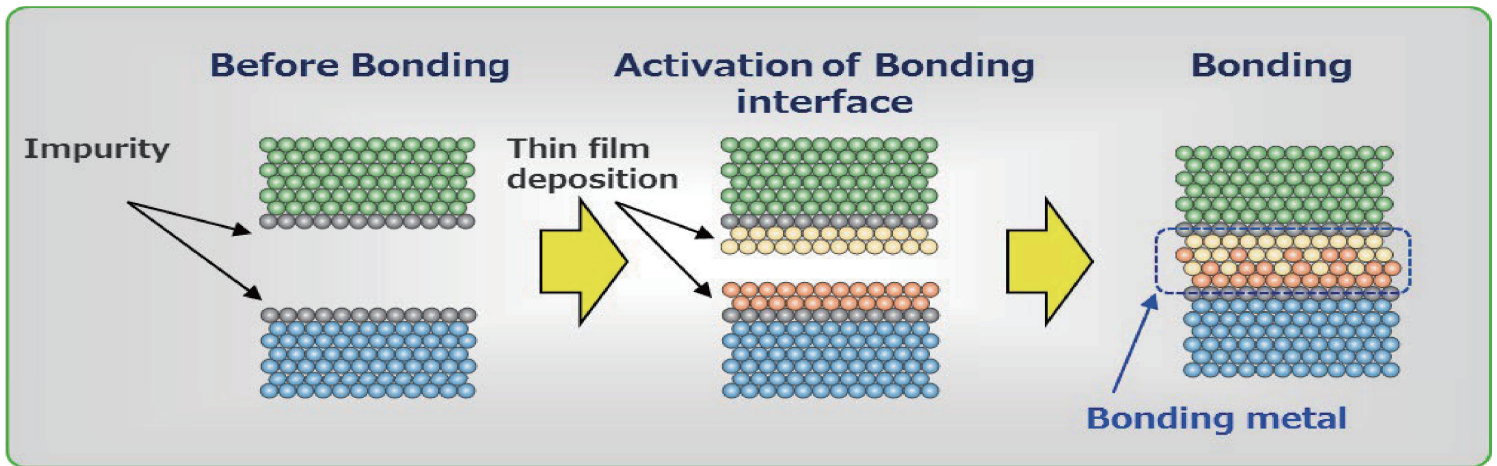


ADB Technique & Results

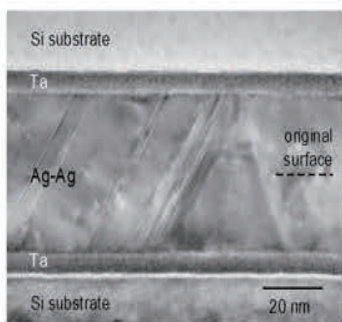
Wafer Level -



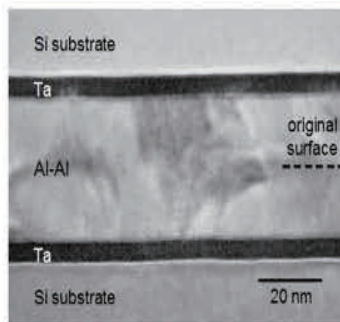
Material Level -



Microstructure Level - Examples
(fcc structure)

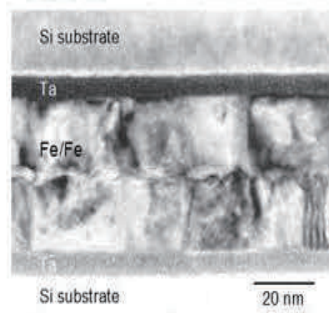


Ag – Ag bond

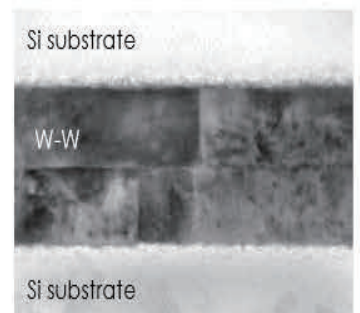


Al – Al bond

(bcc structure)



Fe – Fe bond



W – W bond

Bonding strength depends on D (self diffusion coefficient) of the bonding material

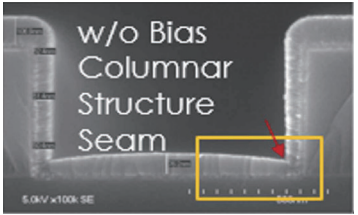

PDC – New Deposition Solution

EC7430 – PDC

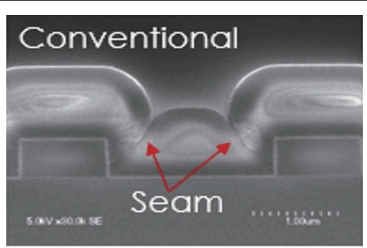
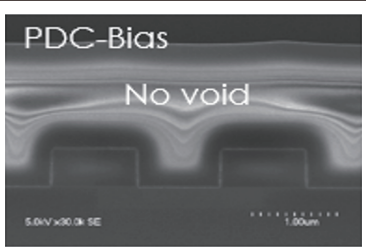
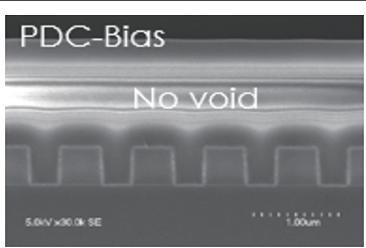
PLABAS (Plasma Balanced System) Dual Cathode

Novel sputtering technology for insulator and dielectric materials. High performance through independent bias control.

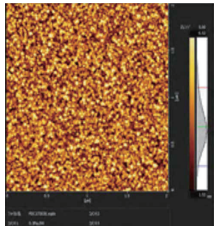
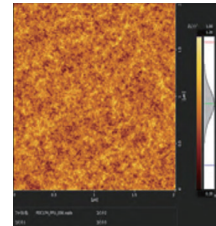
Coverage Quality

d 0.5 μm W 1.0 μm (AR 0.5)			
	Top/Bottom/Sidewall	106.4 nm / 76.2 nm / 50.4 nm	94.1 nm / 70.3 nm / 47.5 nm
	Bottom Coverage%	72%	75%
	Sidewall Coverage%	47%	51%

Trench Filling

	AR = 0.5 (500 nm / 1000 nm)	AR = 1.4 (500 nm / 350 nm)
		

Surface Roughness

	
Sa:0.997 nm Sz:9.653 nm	Sa:0.090 nm Sz:1.240 nm

Less Contamination –

Element	Al	Ti	Cr	Fe	Co	Ni	Cu	In
Detection limit (10 ¹⁰ atoms/cm ²)	56.569	0.707	0.283	0.141	0.141	0.141	0.283	7.071

All Metals below detection limit

SiO₂ film thickness = 35 nm. Condition: 0.3 Pa, 3 kW, bias 250 W

by TXRF

PDC – Hardware Overview

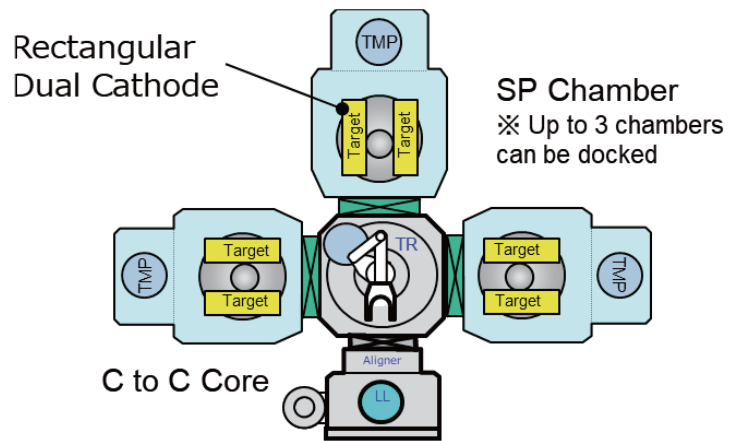
EC7430 – PDC

PLABAS (Plasma Balanced System) Dual Cathode

Tool Outline -

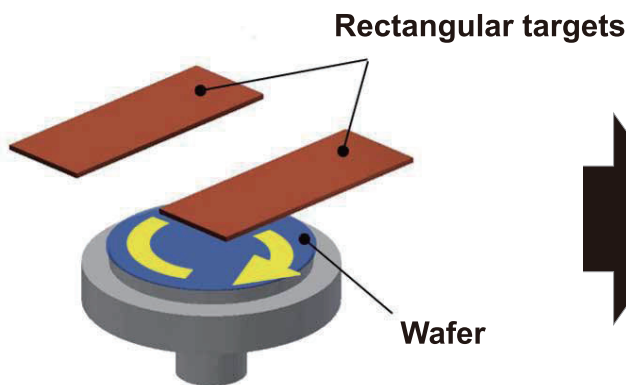


Appearance



HVM Cluster Tool Outline

Unique Dual Cathode Design -



Twin cathodes, substrate rotation, and adjustable target-to-substrate spacing.

